



FEDERAL PTO-1449 (Based on Form PTO-1449)		ATTORNEY DOCKET NO.	SERIAL NO.
PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)		9319H-000603	10/716,940
Sheet 1 of 1		APPLICANT	
		Shinichi Nakamura	
		FILING DATE	GROUP
		November 19, 2003	2861

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

FOREIGN PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes No
1.	<i>MMF</i>	04-070353	3/5/1992	Japan	—	Abstract
2.	<i>MMF</i>	10-151763	6/9/1998	Japan	—	X

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)						
Ref. Desig.	Examiner's Initials					
1.	<i>MMF</i>	Communication from Korean Patent Office re: related application. 9-5-2005-036153212, <i>Notice of Rejection</i> 7-29-05				

*One or more of the English translation documents submitted herewith may be Abstracts only or partial machine created translations from the Japanese Patent Office. As such, the submitter does not necessarily vouch for their accuracy. Additional information may be obtained from the Japanese Patent Office web site at www.jpo.go.jp

Examiner: S. Hsieh Date Considered: 9-13-05

EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM HDP-1449 (Based on Form PTO-1449)		ATTORNEY DOCKET NO.	SERIAL NO.
PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)		9319H-000603	to be assigned
Sheet 1 of 1		APPLICANT	10/716,940
		Shinichi NAKAMURA	
		FILING DATE	GROUP
		herewith NOV. 19, 2023	Unknown 286

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

FOREIGN PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes <input checked="" type="checkbox"/> No <input type="checkbox"/>
1.	MM	2000-211157	8/2/2000	Japan	—	X
2.	MM	10-286974	10/27/1998	Japan	—	X

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)						
Ref. Desig.	Examiner's Initials					
1.						

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Examiner:	<i>S. H. Shul</i>	Date Considered:	<i>9-13-05</i>
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